

<b>Notice of References Cited</b>		Application/Control No. 10/706,858	Applicant(s)/Patent Under Reexamination KIM ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0149733	10-2002	Lyu et al.	349/155
	B	US-2003/0156235	08-2003	Kuzuhara et al.	349/96
	C	US-2004/0001175	01-2004	Ito, Yoji	349/117
	D	US-2004/0180149	09-2004	Shibue et al.	428/001.1
	E	US-2002/0140882	10-2002	Kitagawa et al.	349/96
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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